



**THE DATASHEET OF  
CY7C1049D-10VXI**



# 4-Mbit (512 K × 8) Static RAM

## Features

- Pin- and function-compatible with CY7C1049B
- High speed
  - $t_{AA} = 10 \text{ ns}$
- Low active power
  - $I_{CC} = 90 \text{ mA}$  at 10 ns
- Low CMOS Standby power
  - $I_{SB2} = 10 \text{ mA}$
- 2.0 V data retention
- Automatic power-down when deselected
- TTL-compatible inputs and outputs
- Easy memory expansion with  $\overline{CE}$  and  $\overline{OE}$  features
- Available in Pb-free 36-pin (400-Mil) Molded SOJ package

## Functional Description

The CY7C1049D <sup>[1]</sup> is a high-performance CMOS static RAM organized as 512K words by 8 bits. Easy memory expansion is

provided by an active LOW Chip Enable ( $\overline{CE}$ ), an active LOW Output Enable ( $\overline{OE}$ ), and tri-state drivers. Writing to the device is accomplished by taking Chip Enable ( $\overline{CE}$ ) and Write Enable ( $\overline{WE}$ ) inputs LOW. Data on the eight I/O pins ( $I/O_0$  through  $I/O_7$ ) is then written into the location specified on the address pins ( $A_0$  through  $A_{18}$ ).

Reading from the device is accomplished by taking Chip Enable ( $\overline{CE}$ ) and Output Enable ( $\overline{OE}$ ) LOW while forcing Write Enable ( $\overline{WE}$ ) HIGH. Under these conditions, the contents of the memory location specified by the address pins will appear on the I/O pins.

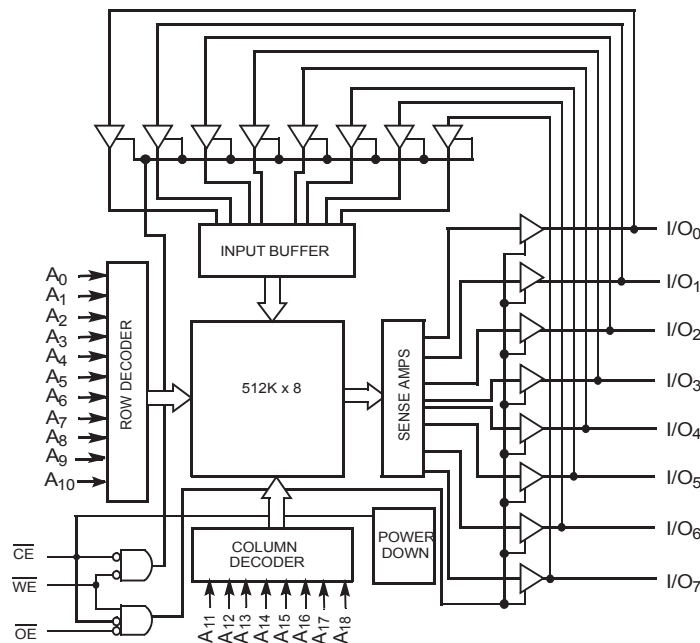
The eight input/output pins ( $I/O_0$  through  $I/O_7$ ) are placed in a high-impedance state when the device is deselected ( $\overline{CE}$  HIGH), the outputs are disabled ( $\overline{OE}$  HIGH), or during a write operation ( $\overline{CE}$  LOW, and  $\overline{WE}$  LOW).

The CY7C1049D is available in a standard 400-mil-wide 36-pin SOJ package with center power and ground (revolutionary) pinout.

The CY7C1049D is suitable for interfacing with processors that have TTL I/P levels. It is not suitable for processors that require CMOS I/P levels. Please see [Electrical Characteristics on page 4](#) for more details and suggested alternatives.

For a complete list of related documentation, [click here](#).

## Logic Block Diagram



### Note

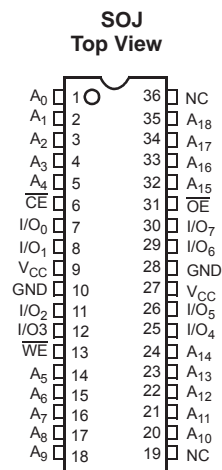
1. For guidelines on SRAM system design, refer to the 'System Design Guidelines' Cypress application note, available on the internet at [www.cypress.com](http://www.cypress.com).

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## Pin Configuration

Figure 1. 36-pin SOJ pinout (Top View)



## Selection Guide

Description	-10	Unit
Maximum access time	10	ns
Maximum operating current	90	mA
Maximum CMOS standby current	10	mA

## Maximum Ratings

Exceeding maximum ratings may shorten the useful life of the device. User guidelines are not tested.

Storage Temperature .....	-65 °C to +150 °C
Ambient Temperature with Power Applied .....	-55 °C to +125 °C
Supply Voltage on V <sub>CC</sub> to Relative GND [2] .....	-0.5 V to +6.0 V
DC Voltage Applied to Outputs in High Z State [2] .....	-0.5 V to V <sub>CC</sub> + 0.5 V

DC Input Voltage [2] .....	-0.5 V to V <sub>CC</sub> + 0.5 V
Current into Outputs (LOW) .....	20 mA
Static Discharge Voltage (per MIL-STD-883, Method 3015) .....	>2001 V
Latch-Up Current .....	>200 mA

## Operating Range

Range	Ambient Temperature	V <sub>CC</sub>
Industrial	-40 °C to +85 °C	4.5 V–5.5 V

## Electrical Characteristics

Over the Operating Range

Parameter	Description	Test Conditions	-10		Unit	
			Min	Max		
V <sub>OH</sub>	Output HIGH Voltage	V <sub>CC</sub> = Min, I <sub>OH</sub> = -4.0 mA	2.4	-	V	
		V <sub>CC</sub> = Max, I <sub>OH</sub> = -0.1mA	-	3.4 [3]		
V <sub>OL</sub>	Output LOW Voltage	V <sub>CC</sub> = Min., I <sub>OL</sub> = 8.0 mA	-	0.4	V	
V <sub>IH</sub> [2]	Input HIGH Voltage		2.0	V <sub>CC</sub> + 0.5	V	
V <sub>IL</sub> [2]	Input LOW Voltage [2]		-0.5	0.8	V	
I <sub>IX</sub>	Input Leakage Current	GND < V <sub>I</sub> < V <sub>CC</sub>	-1	+1	μA	
I <sub>OZ</sub>	Output Leakage Current	GND < V <sub>OUT</sub> < V <sub>CC</sub> , Output Disabled	-1	+1	μA	
I <sub>CC</sub>	VCC Operating Supply Current	V <sub>CC</sub> = Max., f = f <sub>MAX</sub> = 1/t <sub>RC</sub>	100 MHz	-	90	mA
				-		
			83 MHz	-	80	mA
				-		
66 MHz	-	70	mA			
	-					
40 MHz	-	60	mA			
	-					
I <sub>SB1</sub>	Automatic CE Power-Down Current – TTL Inputs	Max. V <sub>CC</sub> , CE > V <sub>IH</sub> , V <sub>IN</sub> > V <sub>IH</sub> or V <sub>IN</sub> < V <sub>IL</sub> , f = f <sub>MAX</sub>	-	20	mA	
I <sub>SB2</sub>	Automatic CE Power-Down Current – CMOS Inputs	Max. V <sub>CC</sub> , CE > V <sub>CC</sub> - 0.3 V, V <sub>IN</sub> > V <sub>CC</sub> - 0.3 V or V <sub>IN</sub> < 0.3 V, f = 0	-	10	mA	

### Notes

- Minimum voltage is -2.0 V and V<sub>IH(max)</sub> = V<sub>CC</sub> + 2 V for pulse durations of less than 20 ns.
- Please note that the maximum V<sub>OH</sub> limit does not exceed minimum CMOS V<sub>IH</sub> of 3.5 V. If you are interfacing this SRAM with 5 V legacy processors that require a minimum V<sub>IH</sub> of 3.5 V, please refer to Application Note [AN6081](#) for technical details and options you may consider.

### Capacitance

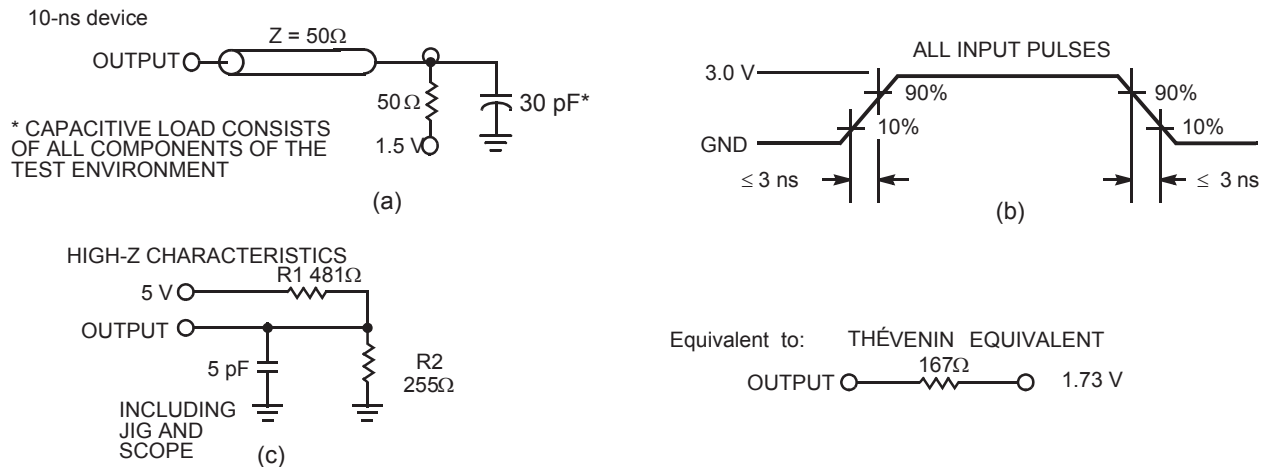
Parameter <sup>[4]</sup>	Description	Test Conditions	Max	Unit
C <sub>IN</sub>	Input capacitance	T <sub>A</sub> = 25 °C, f = 1 MHz, V <sub>CC</sub> = 5.0 V	8	pF
C <sub>OUT</sub>	I/O capacitance		8	pF

### Thermal Resistance

Parameter <sup>[4]</sup>	Description	Test Conditions	SOJ Package	Unit
θ <sub>JA</sub>	Thermal resistance (junction to ambient)	Still Air, soldered on a 3 × 4.5 inch, four-layer printed circuit board	57.91	°C/W
θ <sub>JC</sub>	Thermal resistance (junction to case)		36.73	°C/W

### AC Test Loads and Waveforms

Figure 2. AC Test Loads and Waveforms <sup>[5]</sup>



**Note**

- Tested initially and after any design or process changes that may affect these parameters.
- AC characteristics (except High-Z) for 10-ns parts are tested using the load conditions shown in Figure 2 (a). High-Z characteristics are tested for all speeds using the test load shown in Figure 2 (c).

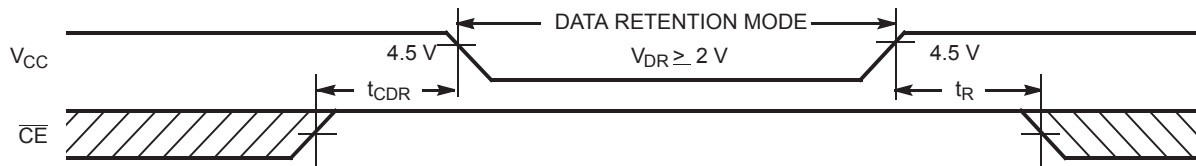
## Data Retention Characteristics

Over the Operating Range

Parameter	Description	Conditions <sup>[6]</sup>	Min	Max	Unit
$V_{DR}$	$V_{CC}$ for Data Retention		2.0	–	V
$I_{CCDR}$	Data Retention Current	$V_{CC} = V_{DR} = 2.0\text{ V}$ ,	–	10	mA
$t_{CDR}^{[7]}$	Chip Deselect to Data Retention Time	$\overline{CE} \geq V_{CC} - 0.3\text{ V}$ ,	0	–	ns
$t_R^{[8]}$	Operation Recovery Time	$V_{IN} \geq V_{CC} - 0.3\text{ V}$ or $V_{IN} \leq 0.3\text{ V}$	$t_{RC}$	–	ns

## Data Retention Waveform

Figure 3. Data Retention Waveform



### Notes

- No input may exceed  $V_{CC} + 0.5\text{ V}$ .
- Tested initially and after any design or process changes that may affect these parameters.
- Full device operation requires linear  $V_{CC}$  ramp from  $V_{DR}$  to  $V_{CC(min.)} \geq 50\ \mu\text{s}$  or stable at  $V_{CC(min.)} \geq 50\ \mu\text{s}$ .

## Switching Characteristics

Over the Operating Range

Parameter <sup>[9]</sup>	Description	-10		Unit
		Min	Max	
<b>Read Cycle</b>				
$t_{power}$	$V_{CC}$ (typical) to the First Access <sup>[10]</sup>	100	–	$\mu$ s
$t_{RC}$	Read Cycle Time	10	–	ns
$t_{AA}$	Address to Data Valid	–	10	ns
$t_{OHA}$	Data Hold from Address Change	3	–	ns
$t_{ACE}$	$\overline{CE}$ LOW to Data Valid	–	10	ns
$t_{DOE}$	$\overline{OE}$ LOW to Data Valid	–	5	ns
$t_{LZOE}$	$\overline{OE}$ LOW to Low Z <sup>[11]</sup>	0	–	ns
$t_{HZOE}$	$\overline{OE}$ HIGH to High Z <sup>[11, 12]</sup>	–	5	ns
$t_{LZCE}$	$\overline{CE}$ LOW to Low Z <sup>[11]</sup>	3	–	ns
$t_{HZCE}$	$\overline{CE}$ HIGH to High Z <sup>[11, 12]</sup>	–	5	ns
$t_{PU}$	$\overline{CE}$ LOW to Power-Up	0	–	ns
$t_{PD}$	$\overline{CE}$ HIGH to Power-Down	–	10	ns
<b>Write Cycle <sup>[13, 14]</sup></b>				
$t_{WC}$	Write Cycle Time	10	–	ns
$t_{SCE}$	$\overline{CE}$ LOW to Write End	7	–	ns
$t_{AW}$	Address Set-Up to Write End	7	–	ns
$t_{HA}$	Address Hold from Write End	0	–	ns
$t_{SA}$	Address Set-Up to Write Start	0	–	ns
$t_{PWE}$	$\overline{WE}$ Pulse Width	7	–	ns
$t_{SD}$	Data Set-Up to Write End	6	–	ns
$t_{HD}$	Data Hold from Write End	0	–	ns
$t_{LZWE}$	$\overline{WE}$ HIGH to Low Z <sup>[11]</sup>	3	–	ns
$t_{HZWE}$	$\overline{WE}$ LOW to High Z <sup>[11, 12]</sup>	–	5	ns

### Notes

9. Test conditions assume signal transition time of 3 ns or less, timing reference levels of 1.5 V, input pulse levels of 0 to 3.0 V, and output loading of the specified  $I_{OL}/I_{OH}$  and 30-pF load capacitance.
10.  $t_{POWER}$  gives the minimum amount of time that the power supply should be at typical  $V_{CC}$  values until the first memory access can be performed.
11. At any given temperature and voltage condition,  $t_{HZCE}$  is less than  $t_{LZCE}$ ,  $t_{HZOE}$  is less than  $t_{LZOE}$ , and  $t_{HZWE}$  is less than  $t_{LZWE}$  for any given device.
12.  $t_{HZOE}$ ,  $t_{HZCE}$ , and  $t_{HZWE}$  are specified with a load capacitance of 5 pF as in part (c) of [Figure 2](#). Transition is measured when the outputs enter a high impedance state.
13. The internal write time of the memory is defined by the overlap of  $\overline{CE}$  LOW, and  $\overline{WE}$  LOW.  $\overline{CE}$  and  $\overline{WE}$  must be LOW to initiate a write, and the transition of either of these signals can terminate the write. The input data set-up and hold timing should be referenced to the leading edge of the signal that terminates the write.
14. The minimum write cycle time for Write Cycle No. 3 ( $\overline{WE}$  Controlled,  $\overline{OE}$  LOW) is the sum of  $t_{HZWE}$  and  $t_{SD}$ .

### Switching Waveforms

Figure 4. Read Cycle No. 1 [15, 16]

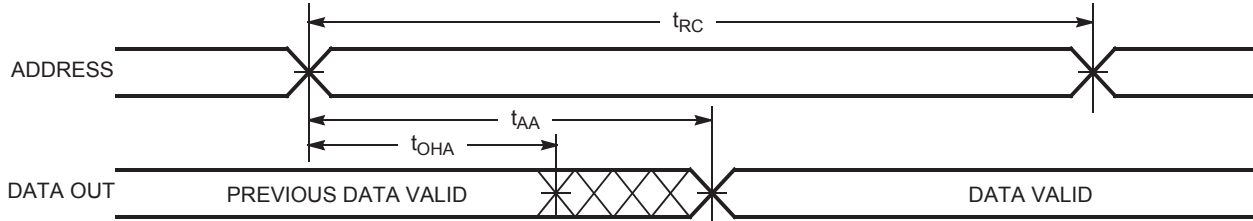
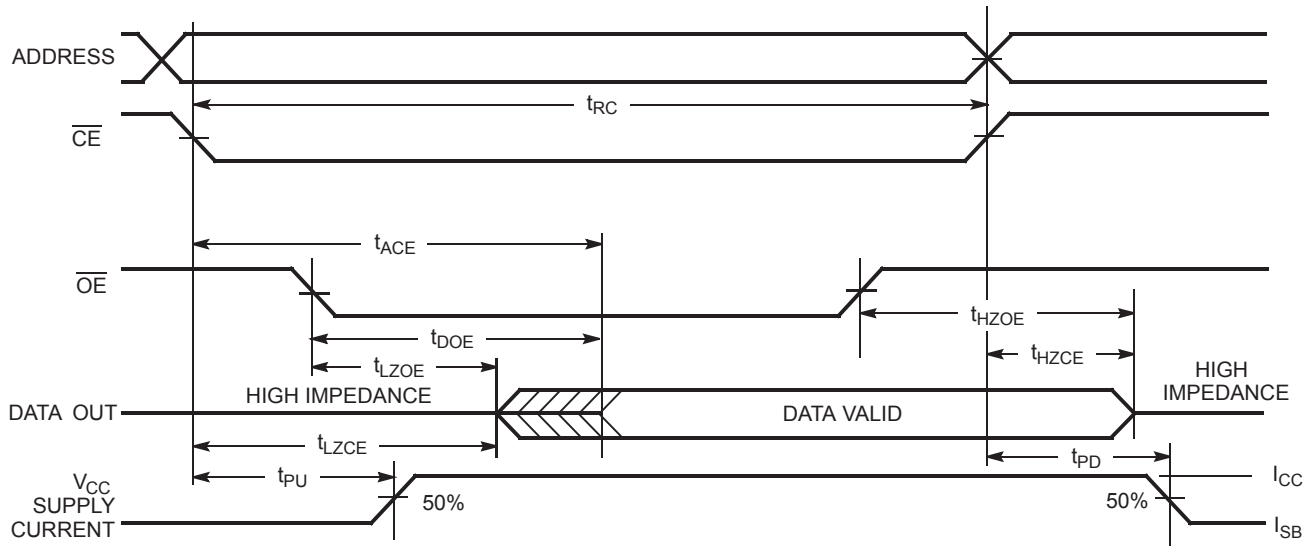


Figure 5. Read Cycle No. 2 ( $\overline{OE}$  Controlled) [16, 17]



**Notes**

15. Device is continuously selected.  $\overline{OE}$ ,  $\overline{CE} = V_{IL}$ .

16.  $\overline{WE}$  is HIGH for read cycle.

17. Address valid prior to or coincident with  $\overline{CE}$  transition LOW.

Switching Waveforms(continued)

Figure 6. Write Cycle No. 1 ( $\overline{\text{CE}}$  Controlled) [18, 19]

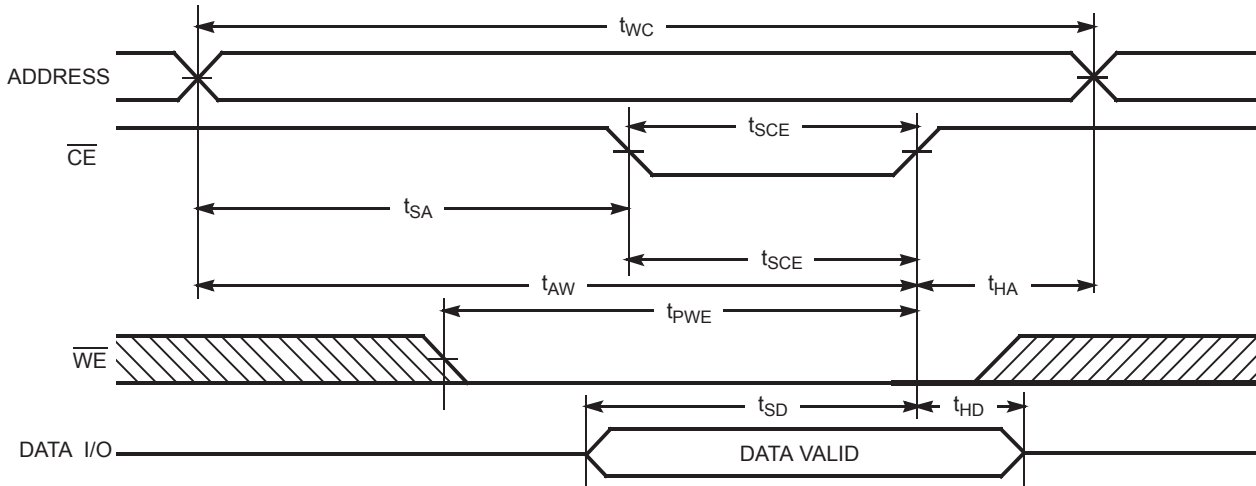
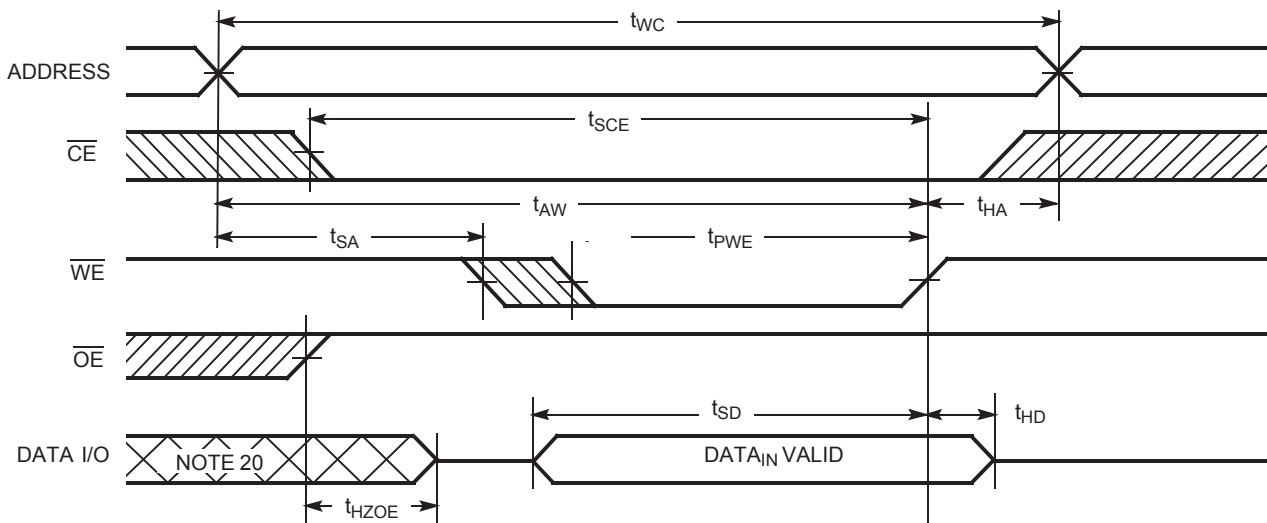


Figure 7. Write Cycle No. 2 ( $\overline{\text{WE}}$  Controlled,  $\overline{\text{OE}}$  HIGH During Write) [18, 19]

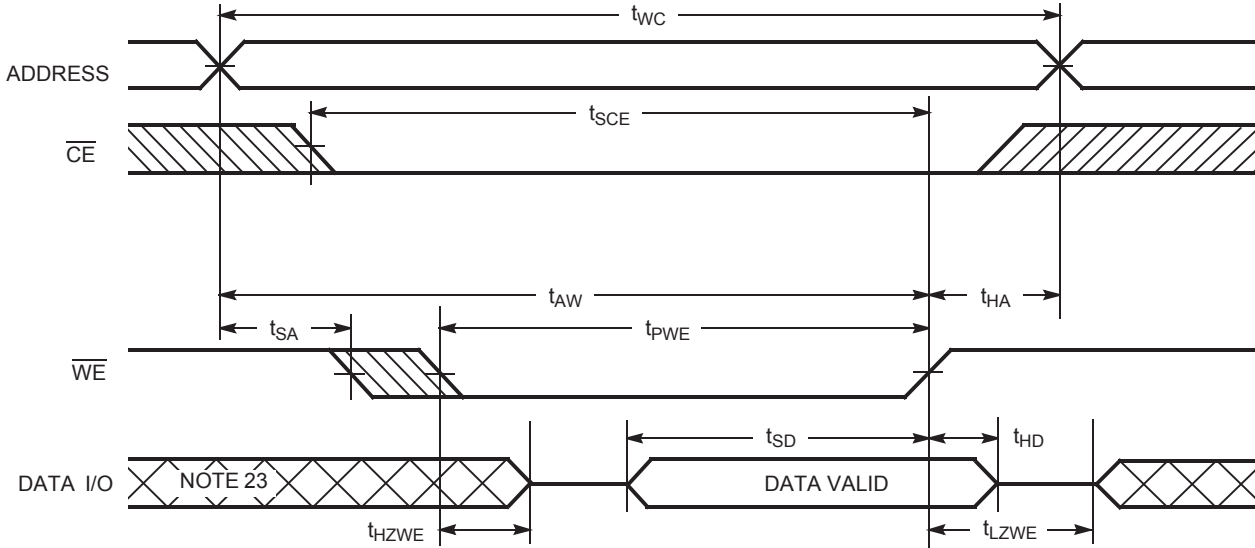


Notes

- 18. Data I/O is high impedance if  $\overline{\text{OE}} = V_{IH}$ .
- 19. If  $\overline{\text{CE}}$  goes HIGH simultaneously with  $\overline{\text{WE}}$  going HIGH, the output remains in a high-impedance state.
- 20. During this period the I/Os are in the output state and input signals should not be applied.

Switching Waveforms(continued)

Figure 8. Write Cycle No. 3 ( $\overline{WE}$  Controlled,  $\overline{OE}$  LOW) [21, 22]



Note

- 21. If  $\overline{CE}$  goes HIGH simultaneously with  $\overline{WE}$  going HIGH, the output remains in a high-impedance state.
- 22. The minimum write cycle time for Write Cycle No. 3 ( $\overline{WE}$  controlled,  $\overline{OE}$  LOW) is the sum of  $t_{HZWE}$  and  $t_{SD}$ .
- 23. During this period the I/Os are in the output state and input signals should not be applied.

### Truth Table

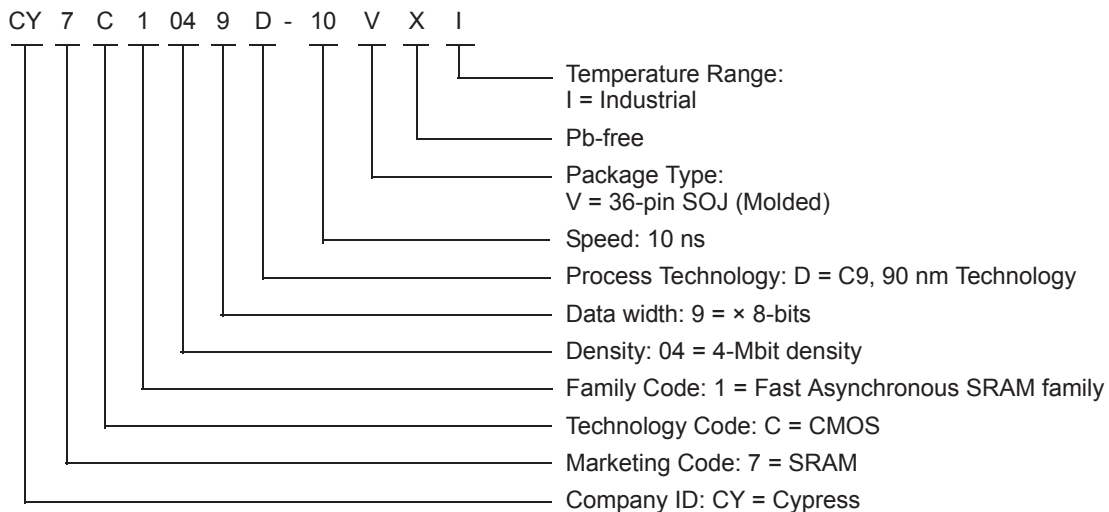
$\overline{CE}$	$\overline{OE}$	$\overline{WE}$	I/O <sub>0</sub> -I/O <sub>7</sub>	Mode	Power
H	X	X	High-Z	Power-down	Standby (I <sub>SB</sub> )
L	L	H	Data Out	Read	Active (I <sub>CC</sub> )
L	X	L	Data In	Write	Active (I <sub>CC</sub> )
L	H	H	High-Z	Selected, Outputs Disabled	Active (I <sub>CC</sub> )

### Ordering Information

Speed (ns)	Ordering Code	Package Diagram	Package Type	Operating Range
10	CY7C1049D-10VXI	51-85090	36-pin SOJ (Molded) Pb-free	Industrial

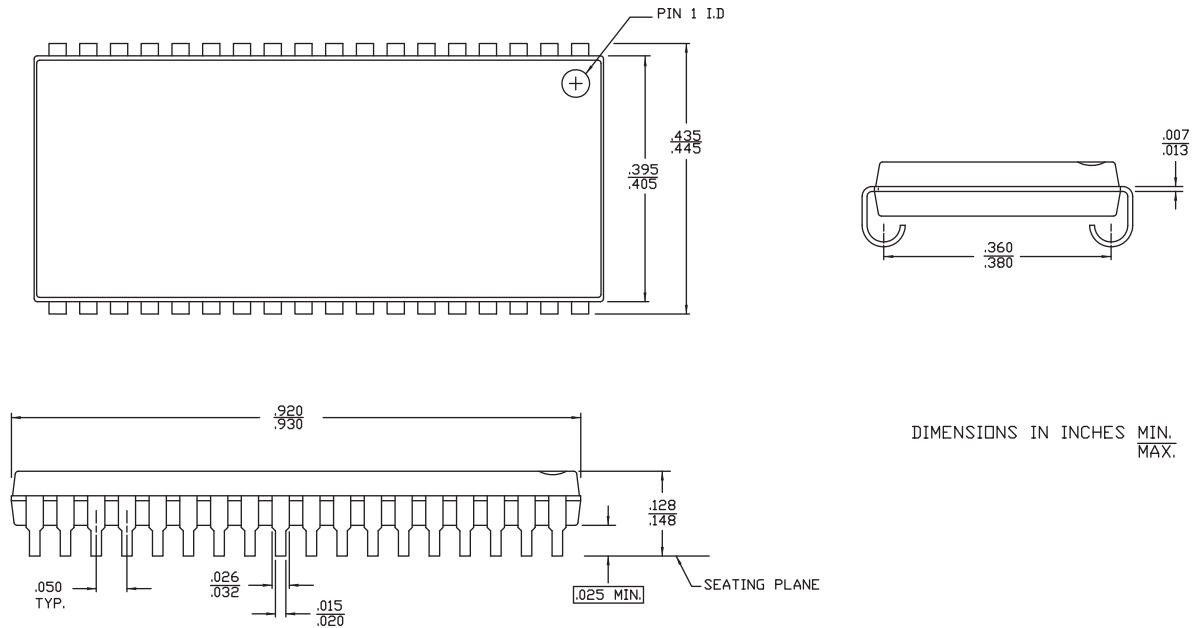
Please contact your local Cypress sales representative for availability of these parts.

### Ordering Code Definitions



Package Diagram

Figure 9. 36-pin SOJ V36.4 (Molded) Package Outline, 51-85090



51-85090 \*F

### Acronyms

Acronym	Description
$\overline{CE}$	Chip Enable
CMOS	Complementary Metal Oxide Semiconductor
I/O	Input/Output
$\overline{OE}$	Output Enable
SRAM	Static Random Access Memory
SOJ	Small Outline J-Lead
VFBGA	Very Fine-Pitch Ball Grid Array

### Document Conventions

#### Units of Measure

Symbol	Unit of Measure
$^{\circ}C$	degree Celsius
MHz	megahertz
$\mu A$	microampere
mA	milliampere
mV	millivolt
mW	milliwatt
ns	nanosecond
pF	picofarad
V	volt
W	watt

Document History Page

Document Title: CY7C1049D, 4-Mbit (512 K x 8) Static RAM Document Number: 38-05474				
Revision	ECN	Orig. of Change	Submission Date	Description of Change
**	201560	SWI	See ECN	Advance Datasheet for C9 IPP
*A	233729	RKF	See ECN	1.AC, DC parameters are modified as per EROS(Spec # 01-2165) 2.Pb-free offering in the 'ordering information'
*B	351096	PCI	See ECN	Changed from Advance to Preliminary Removed 17, 20 ns Speed bin Added footnote # 4 Redefined I <sub>CC</sub> values for Com'l and Ind'l temperature ranges I <sub>CC</sub> (Com'l): Changed from 67 and 54 mA to 75 and 70 mA for 12 and 15 ns speed bins respectively I <sub>CC</sub> (Ind'l): Changed from 80, 67 and 54 mA to 90, 85 and 80 mA for 10, 12 and 15 ns speed bins respectively Added V <sub>IH(max)</sub> spec in Note# 2 Modified Note# 10 on t <sub>R</sub> Changed t <sub>SCE</sub> from 8 to 7 ns for 10 ns speed bin Changed reference voltage level for measurement of Hi-Z parameters from ±500 mV to ±200 mV Added Truth Table on page# 6 Removed L-Version Added 10 ns parts in the Ordering Information Table Added Lead-Free Product Information Shaded Ordering Information Table
*C	446328	NXR	See ECN	Converted from Preliminary to Final Removed -12 and -15 speed bins Removed Commercial Operating Range product information Changed Maximum Rating for supply voltage from 7 V to 6 V Updated Thermal Resistance table Changed t <sub>HZWE</sub> from 6 ns to 5 ns Updated footnote #7 on High-Z parameter measurement Replaced Package Name column with Package Diagram in the Ordering Information table
*D	3109184	AJU	12/13/2010	Added <a href="#">Ordering Code Definitions</a> . Updated <a href="#">Package Diagram</a> .
*E	3235742	PRAS	04/20/2011	Added Acronyms and Units of measure. Updated template.
*F	4040855	MEMJ	06/26/2013	Updated <a href="#">Functional Description</a> . Updated <a href="#">Electrical Characteristics</a> : Added one more Test Condition "V <sub>CC</sub> = Max, I <sub>OH</sub> = -0.1mA" for V <sub>OH</sub> parameter and added maximum value corresponding to that Test Condition. Added Note 3 and referred the same note in maximum value for V <sub>OH</sub> parameter corresponding to Test Condition "V <sub>CC</sub> = Max, I <sub>OH</sub> = -0.1mA". Updated <a href="#">Package Diagram</a> : spec 51-85090 – Changed revision from *E to *F. Updated in new template.
*G	4391976	MEMJ	05/28/2014	Updated <a href="#">Switching Waveforms</a> : Added Note 22 and referred the same note in <a href="#">Figure 8</a> . Completing Sunset Review.
*H	4578500	MEMJ	11/24/2014	Added related documentation hyperlink in page 1.

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